

Notice of References Cited	Application/Control No. 10/792,257		Applicant(s)/Patent Under Reexamination STEYSKAL ET AL.	
	Examiner Nguyen T Ha		Art Unit 2831	Page 1 of 1

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-6,795,295	09-2004	Murakami et al.	361/306.3
*	B	US-6,606,237	08-2003	Naito et al.	361/306.3
*	C	US-6,594,136	07-2003	Kuroda et al.	361/306.1
*	D	US-6,549,395	04-2003	Naito et al.	361/306.1
*	E	US-6,462,933	10-2002	Takeshima et al.	361/306.3
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	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

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NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
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